Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/604,840	HO, CHIN-TE
Examiner	Art Unit
Joseph Chang	2817

SEARCHED						
Class	Subclass	Date	Examiner			
331	25,1A DIG.3 DIG.2	2/7/2005	JC			
377	39,43 42					
327	48,49 42					
324	76.79					
324	76.62					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (attached)	2/7/2005	1C		